

Super FAP-G Series**N-CHANNEL SILICON POWER MOSFET****■ Features**

High speed switching
Low on-resistance
No secondary breakdown
Low driving power
Avalanche-proof

■ Applications

Switching regulators
UPS (Uninterruptible Power Supply)
DC-DC converters

■ Maximum ratings and characteristic Absolute maximum ratings**● (Tc=25°C unless otherwise specified)**

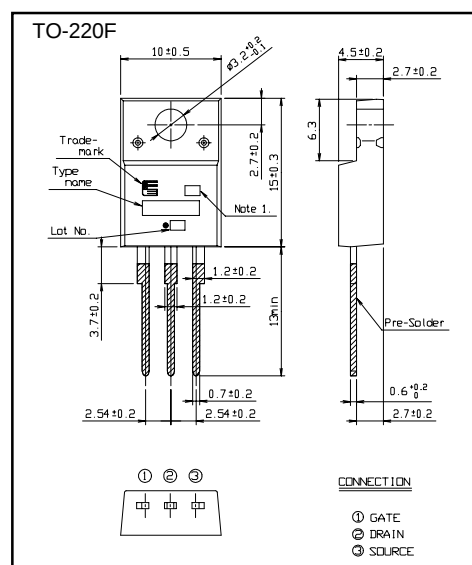
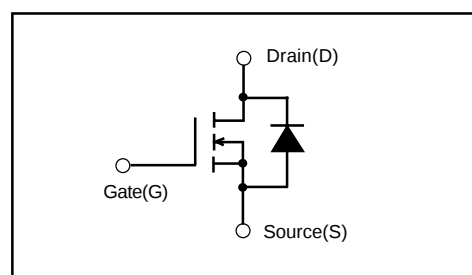
Item	Symbol	Ratings	Unit
Drain-source voltage	V _{DS}	500	V
Continuous drain current	I _D	±9	A
Pulsed drain current	I _D (puls)	±36	A
Gate-source voltage	V _{GS}	±30	V
Repetitive or non-repetitive	I _{AR} *2	9	A
Maximum Avalanche Energy	E _{AS} *1	155.3	mJ
Maximum Drain-Source dV/dt	dV _{DS} /dt *4	20	kV/μs
Peak Diode Recovery dV/dt	dV/dt *3	5	kV/μs
Max. power dissipation	P _D	T _a =25°C	2.16
		T _c =25°C	48
Operating and storage temperature range	T _{ch}	+150	°C
	T _{stg}	-55 to +150	°C
Isolation Voltage	V _{ISO} *5	2	kVrms

*1 L=3.5mH, V_{CC}=50V, See to Avalanche Energy Graph *2 T_{ch}≤150°C*3 I_F≤-I_D, -di/dt=50A/μs, V_{CC}≤BV_{DSS}, T_{ch}≤150°C *4 V_{DS}≤500V *5 t=60sec, f=60Hz**● Electrical characteristics (T_c =25°C unless otherwise specified)**

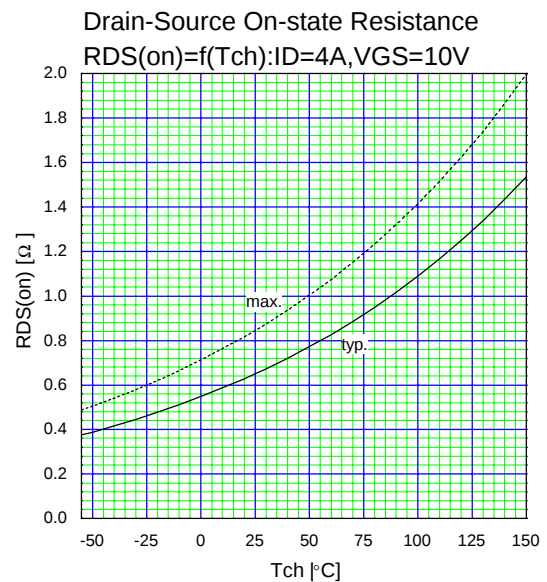
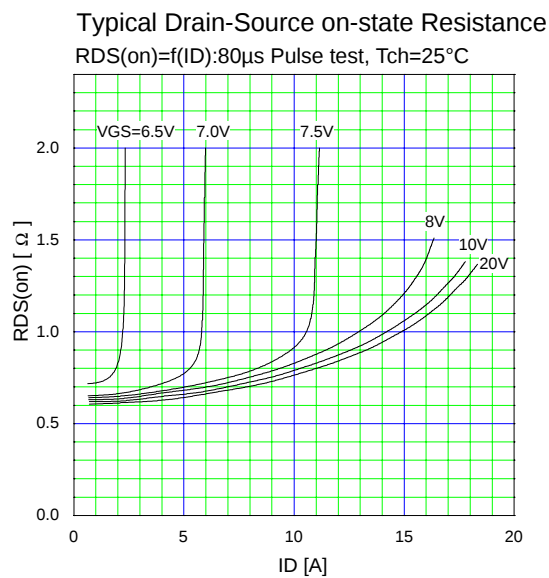
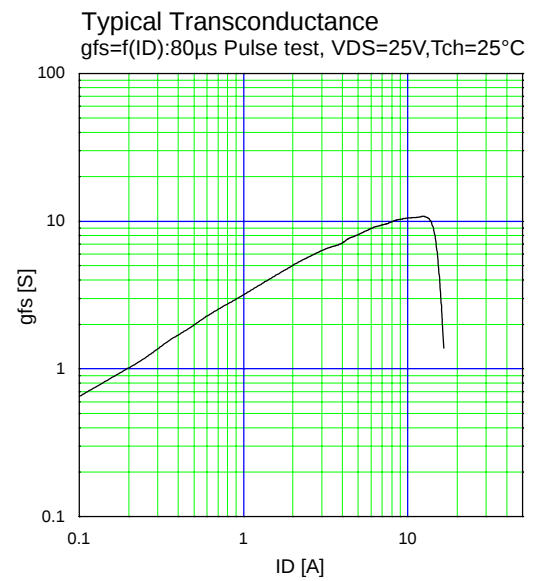
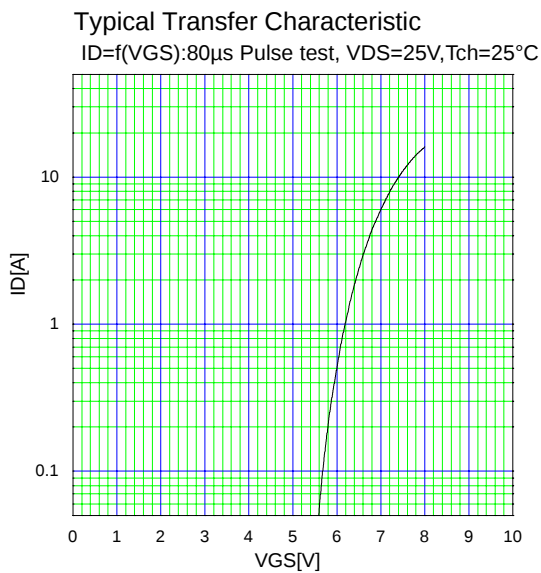
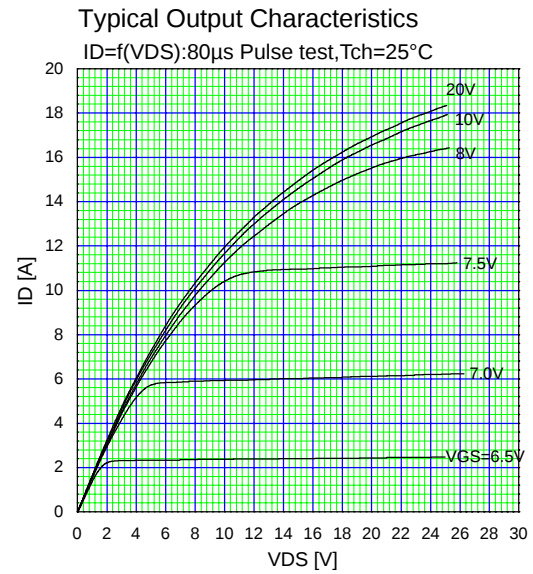
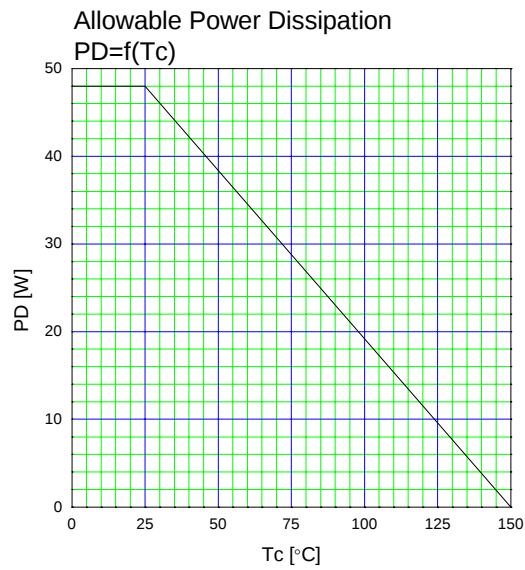
Item	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Drain-source breakdown voltage	V(BR) _{DSS}	I _D = 250μA V _{GS} =0V	500			V
Gate threshold voltage	V _{GS(th)}	I _D = 250μA V _{DS} =V _{GS}	3.0		5.0	V
Zero gate voltage drain current	I _{DSS}	V _{DS} =500V V _{GS} =0V T _{ch} =25°C			25	μA
		V _{DS} =400V V _{GS} =0V T _{ch} =125°C			250	
Gate-source leakage current	I _{GSS}	V _{GS} =±30V V _{DS} =0V		10	100	nA
Drain-source on-state resistance	R _{DS(on)}	I _D =4A V _{GS} =10V		0.65	0.85	Ω
Forward transconductance	g _{fs}	I _D =4A V _{DS} =25V	3.5	7		S
Input capacitance	C _{iss}	V _{DS} =25V		750	1130	pF
Output capacitance	C _{oss}	V _{GS} =0V		100	150	
Reverse transfer capacitance	C _{rss}	f=1MHz		4.0	6.0	
Turn-on time t _{on}	td(on)	V _{CC} =300V I _D =4A		14	21	ns
	t _r	V _{GS} =10V		9	14	
Turn-off time t _{off}	td(off)	R _{GS} =10Ω		24	36	
	t _r			6	9	
Total Gate Charge	Q _G	V _{CC} =250V		20	30	nC
Gate-Source Charge	Q _{GS}	I _D =8A		8.5	13	
Gate-Drain Charge	Q _{GD}	V _{GS} =10V		5.5	8.5	
Avalanche capability	I _{AV}	L=3.5mH T _{ch} =25°C	9			A
Diode forward on-voltage	V _{SD}	I _F =8A V _{GS} =0V T _{ch} =25°C		1.00	1.50	V
Reverse recovery time	t _{rr}	I _F =8A V _{GS} =0V		0.65		μs
Reverse recovery charge	Q _{rr}	-di/dt=100A/μs T _{ch} =25°C		3.5		μC

● Thermal characteristics

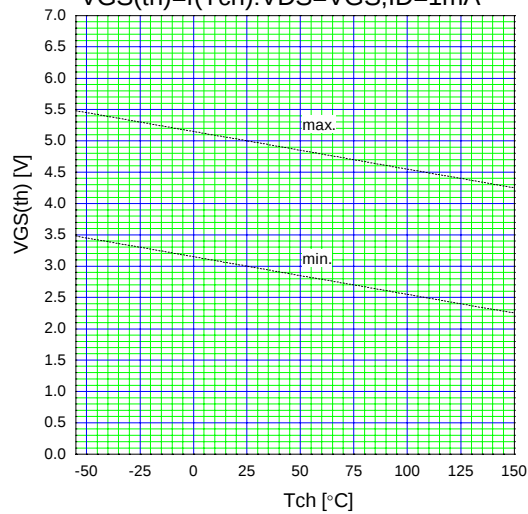
Item	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Thermal resistance	R _{th(ch-c)}	channel to case			2.60	°C/W
	R _{th(ch-a)}	channel to ambient			58.0	°C/W

■ Outline Drawings [mm]**■ Equivalent circuit schematic**

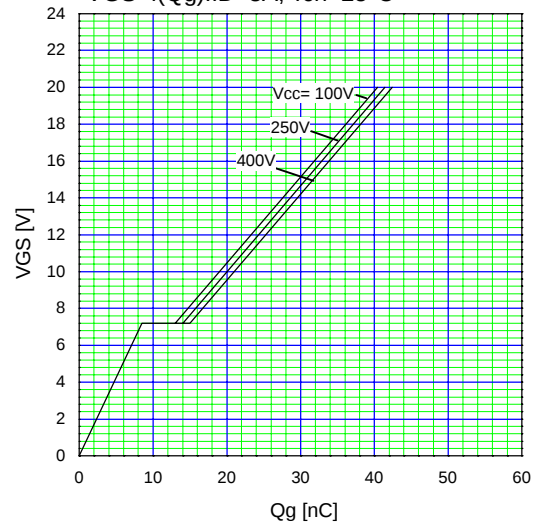
■ Characteristics



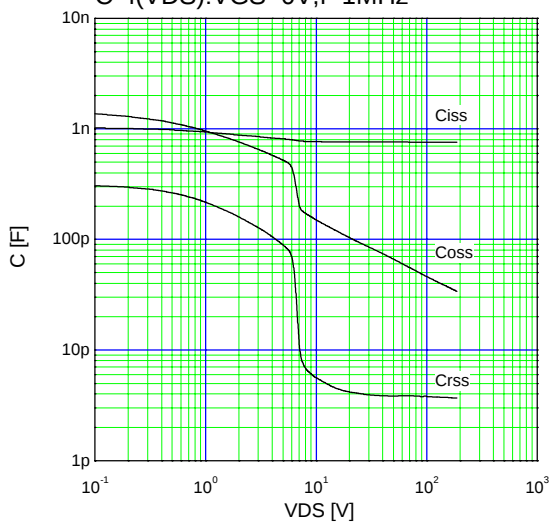
Gate Threshold Voltage vs. T_{ch}
 $V_{GS(th)} = f(T_{ch})$: $V_{DS} = V_{GS}$, $I_D = 1\text{mA}$



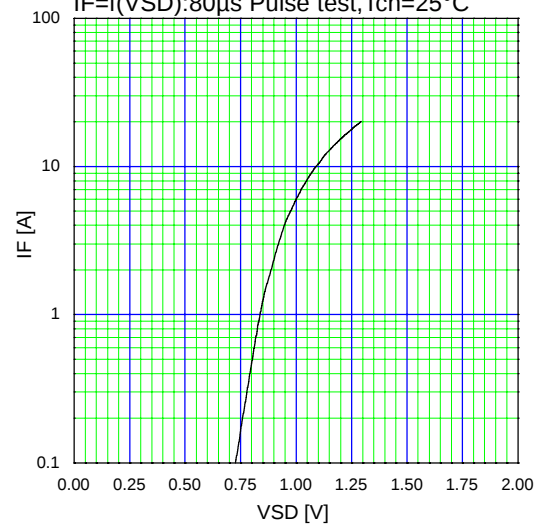
Typical Gate Charge Characteristics
 $V_{GS} = f(Q_g)$: $I_D = 8\text{A}$, $T_{ch} = 25^\circ\text{C}$



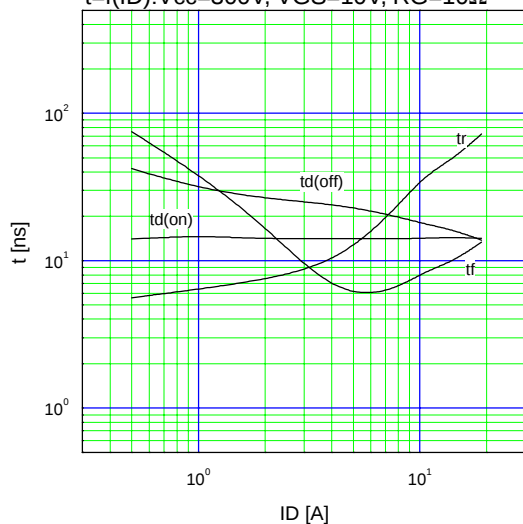
Typical Capacitance
 $C = f(V_{DS})$: $V_{GS} = 0\text{V}$, $f = 1\text{MHz}$



Typical Forward Characteristics of Reverse Diode
 $I_F = f(V_{SD})$: 80μs Pulse test, $T_{ch} = 25^\circ\text{C}$



Typical Switching Characteristics vs. I_D
 $t = f(I_D)$: $V_{CC} = 300\text{V}$, $V_{GS} = 10\text{V}$, $R_G = 10\Omega$



Maximum Avalanche Energy vs. starting T_{ch}
 $E_{AS} = f(\text{starting } T_{ch})$: $V_{CC} = 50\text{V}$

